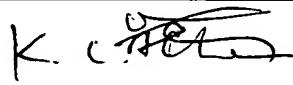
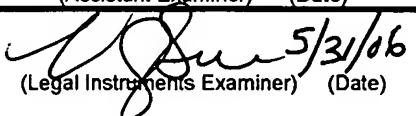


<b>Issue Classification</b> 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/687,424		LIAW, JHON JHY	
	Examiner		Art Unit	
	Kin-Chan Chen		1765	

## ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
438	719	438	706
INTERNATIONAL CLASSIFICATION			
H	0	1	L
21/302			
		/	
		/	
		/	
		/	

  
 Kin-Chan Chen 05/22/2006  
 (Primary Examiner) (Date)

(Assistant Examiner)	(Date)	Total Claims Allowed: 22
 (Legal Instruments Examiner)	(Date)	O.G. Print Claim(s) 1
		O.G. Print Fig. 3

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
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